imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

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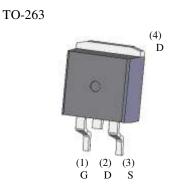
Features

- V_{(BR)DSS} ------100 V (I_D = 100 μA)
 I_D ------66 A
- $\bar{R}_{DS(ON)}$ ------- 12.1 m Ω max. (V_{GS} = 10 V, I_D = 33.0 A) • Q_g -----45.2 nC (V_{GS} = 4.5 V, V_{DS} = 50 V, I_D = 33.0 A)
- Low Total Gate Charge
- High Speed Switching
- Low On-Resistance
- Capable of 4.5 V Gate Drive
- 100 % UIL Tested
- RoHS Compliant

Applications

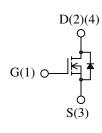
- DC-DC converters
- Synchronous Rectification
- Power Supplies

Package



Not to scale

Equivalent circuit



Absolute Maximum Ratings

• Unless otherwise specified, $T_A = 25 \ ^{\circ}C$

Parameter	Symbol	Test conditions	Rating	Unit
Drain to Source Voltage	V _{DS}		100	V
Gate to Source Voltage	V _{GS}		± 20	V
Continuous Drain Current	I _D	$T_C = 25 \ ^{\circ}C$	66	А
Pulsed Drain Current	I _{DM}	$PW \le 100 \mu s$ Duty cycle $\le 1 \%$	132	А
Continuous Source Current (Body Diode)	Is		66	А
Pulsed Source Current (Body Diode)	I _{SM}	$\begin{array}{l} PW \leq 100 \mu s \\ Duty \ cycle \leq 1 \ \% \end{array}$	132	А
Single Pulse Avalanche Energy	E _{AS}	$V_{DD} = 50 \text{ V}, \text{ L} = 1 \text{ mH},$ $I_{AS} = 13 \text{ A}, \text{ unclamped},$ $R_{G} = 4.7 \Omega,$ Refer to Figure 1	170	mJ
Avalanche Current	I _{AS}		30	А
Power Dissipation	P _D	$T_{\rm C} = 25 \ ^{\circ}{\rm C}$	135	W
Operating Junction Temperature	T _J		150	°C
Storage Temperature Range	T _{STG}		– 55 to 150	°C

Thermal Characteristics

• Unless otherwise specified, $T_A = 25 \ ^{\circ}C$

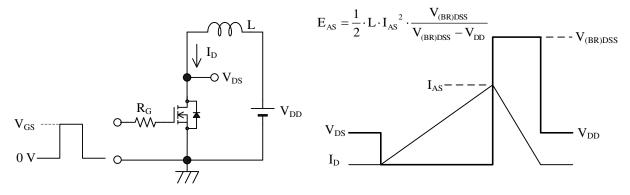
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Thermal Resistance (Junction to Case)	$R_{\theta JC}$		-	_	0.9	°C/W
Thermal Resistance (Junction to Ambient)	$R_{\theta JA}$		_	_	62.5	°C/W

Electrical Characteristics

• Unless otherwise specified, $T_A = 25 \ ^{\circ}C$

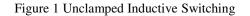
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 100 \ \mu A, V_{GS} = 0 \ V$	100	_	_	V
Drain to Source Leakage Current	I _{DSS}	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$	_	_	100	μA
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 1.5 \text{ mA}$	1.0	2.0	2.5	V
Static Drain to Source	D	$I_{\rm D}$ = 33.0 A, $V_{\rm GS}$ = 10 V	-	8.8	12.1	mΩ
On-Resistance	R _{DS(ON)}	$I_D = 16.5 \text{ A}, V_{GS} = 4.5 \text{ V}$	-	9.6	12.9	mΩ
Gate Resistance	R _G	f = 1 MHz	_	0.8	_	Ω
Input Capacitance	C _{iss}	$V_{DS} = 25 V$ $V_{GS} = 0 V$ $f = 1 MHz$	_	6420	_	pF
Output Capacitance	C _{oss}		_	465	_	
Reverse Transfer Capacitance	C _{rss}		_	280	-	
Total Gate Charge ($V_{GS} = 10 \text{ V}$)	Q _{g1}	$V_{DS} = 50 V$ $I_D = 33.0 A$	-	95.6	-	nC
Total Gate Charge (V_{GS} = 4.5 V)	Q _{g2}		_	45.2	-	
Gate to Source Charge	Q _{gs}		_	16.6	_	
Gate to Drain Charge	Q _{gd}		_	12.4	_	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 50 V$ $I_D = 33.0 A$ $V_{GS} = 10 V, R_G = 4.7 Ω$ Refer to Figure 2	_	10.7	_	ns
Rise Time	t _r		_	10.1	_	
Turn-Off Delay Time	$t_{d(off)}$		_	52.8	_	
Fall Time	t _f		_	21.4	_	
Source to Drain Diode Forward Voltage	V _{SD}	$I_{\rm S} = 33.0 \text{ A}, V_{\rm GS} = 0 \text{ V}$	_	0.9	1.5	V
Source to Drain Diode Reverse Recovery Time	t _{rr}	$I_F = 33.0 \text{ A}$ di/dt = 100 A/µs Refer to Figure 3	_	54.6	_	ns
Source to Drain Diode Reverse Recovery Charge	Qrr		-	106.6	_	nC

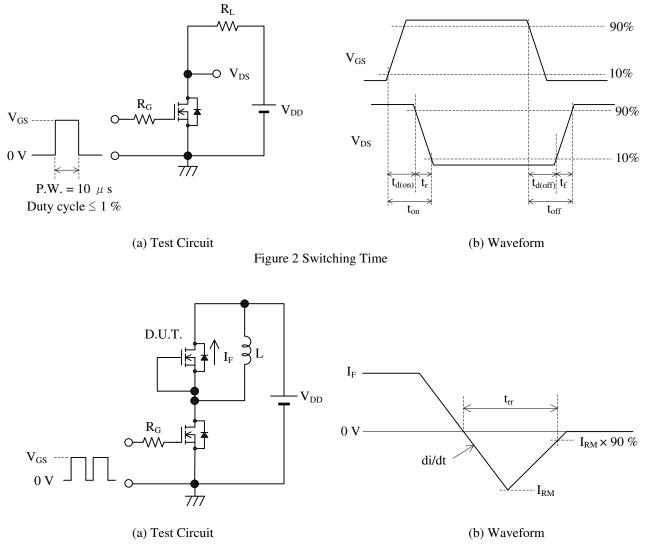
Test Circuits and Waveforms

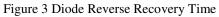


(a) Test Circuit

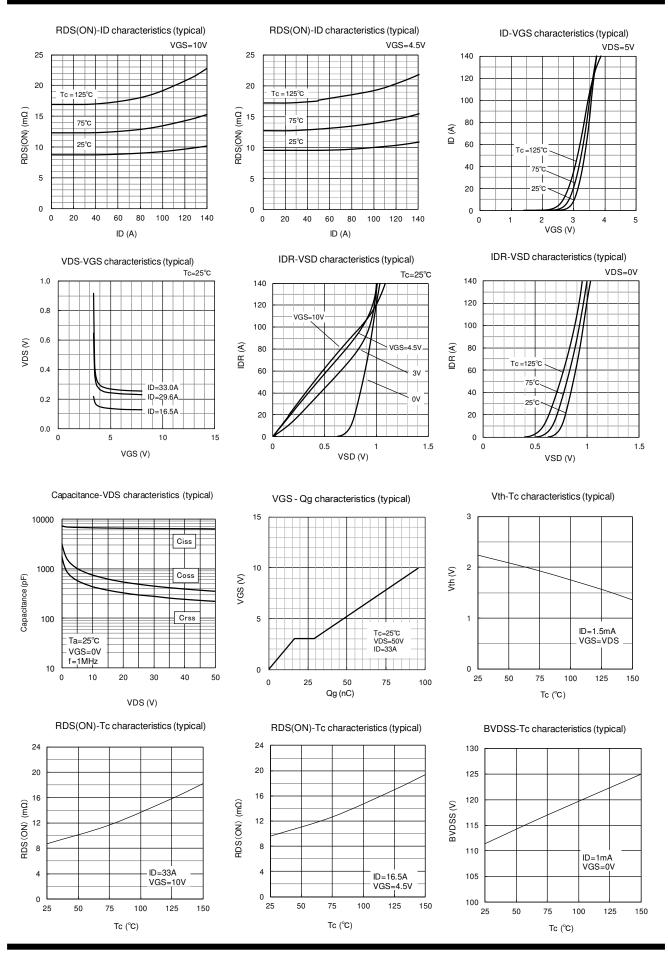
(b) Waveform



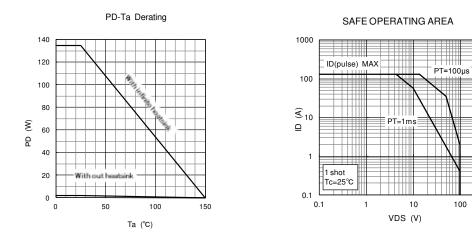


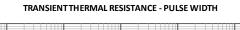


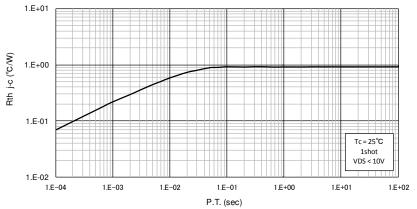
SKI10123



SKI10123-DS Rev.1.3 May. 23, 2014 SANKEN ELECTRIC CO., LTD.

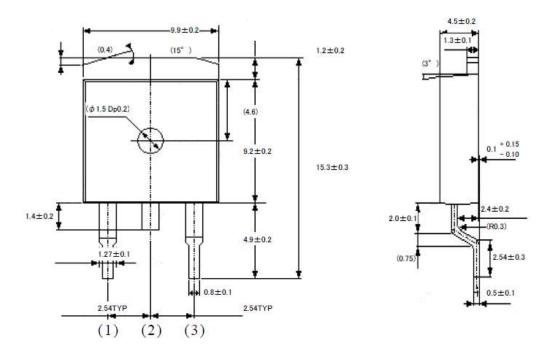






Package Outline

TO-263

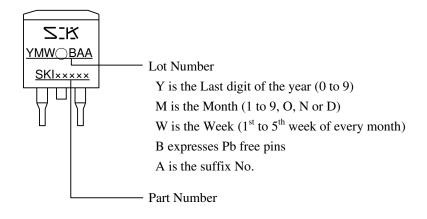


NOTES:

1) Dimension is in millimeters

2) Pb-free. Device composition compliant with the RoHS directive

Marking Diagram



OPERATING PRECAUTIONS

In the case that you use Sanken products or design your products by using Sanken products, the reliability largely depends on the degree of derating to be made to the rated values. Derating may be interpreted as a case that an operation range is set by derating the load from each rated value or surge voltage or noise is considered for derating in order to assure or improve the reliability. In general, derating factors include electric stresses such as electric voltage, electric current, electric power etc., environmental stresses such as ambient temperature, humidity etc. and thermal stress caused due to self-heating of semiconductor products. For these stresses, instantaneous values, maximum values and minimum values must be taken into consideration. In addition, it should be noted that since power devices or IC's including power devices have large self-heating value, the degree of derating of junction temperature affects the reliability significantly.

Because reliability can be affected adversely by improper storage environments and handling methods, please observe the following cautions.

Cautions for Storage

- Ensure that storage conditions comply with the standard temperature (5 to 35°C) and the standard relative humidity (around 40 to 75%); avoid storage locations that experience extreme changes in temperature or humidity.
- Avoid locations where dust or harmful gases are present and avoid direct sunlight.
- Reinspect for rust on leads and solderability of the products that have been stored for a long time.

Cautions for Testing and Handling

When tests are carried out during inspection testing and other standard test periods, protect the products from power surges from the testing device, shorts between the product pins, and wrong connections. Ensure all test parameters are within the ratings specified by Sanken for the products.

Remarks About Using Thermal Silicone Grease

- When thermal silicone grease is used, it shall be applied evenly and thinly. If more silicone grease than required is applied, it may produce excess stress.
- The thermal silicone grease that has been stored for a long period of time may cause cracks of the greases, and it cause low radiation performance. In addition, the old grease may cause cracks in the resin mold when screwing the products to a heatsink.
- Fully consider preventing foreign materials from entering into the thermal silicone grease. When foreign material is immixed, radiation performance may be degraded or an insulation failure may occur due to a damaged insulating plate.
- The thermal silicone greases that are recommended for the resin molded semiconductor should be used. Our recommended thermal silicone grease is the following, and equivalent of these.

Туре	Suppliers
G746	Shin-Etsu Chemical Co., Ltd.
YG6260	Momentive Performance Materials Japan LLC
SC102	Dow Corning Toray Co., Ltd.

Soldering

When soldering the products, please be sure to minimize the working time, within the following limits:

Preheat ; 180 °C / 90 ± 30 s

Solder heating ; 250 °C / 10 \pm 1s (260 °C peak, 2 times)

•Soldering iron ; $380 \pm 10 \text{ °C} / 3.5 \pm 0.5 \text{ s} (1 \text{ time})$

Electrostatic Discharge

•Reflow

- When handling the products, the operator must be grounded. Grounded wrist straps worn should have at least 1MΩ of resistance from the operator to ground to prevent shock hazard, and it should be placed near the operator.
- Workbenches where the products are handled should be grounded and be provided with conductive table and floor mats.
- When using measuring equipment such as a curve tracer, the equipment should be grounded.
- When soldering the products, the head of soldering irons or the solder bath must be grounded in order to prevent leak voltages generated by them from being applied to the products.
- The products should always be stored and transported in Sanken shipping containers or conductive containers, or be wrapped in aluminum foil.

IMPORTANT NOTES

- The contents in this document are subject to changes, for improvement and other purposes, without notice. Make sure that this is the latest revision of the document before use.
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- Sanken products listed in this document are designed and intended for the use as components in general purpose electronic equipment or apparatus (home appliances, office equipment, telecommunication equipment, measuring equipment, etc.).

When considering the use of Sanken products in the applications where higher reliability is required (transportation equipment and its control systems, traffic signal control systems or equipment, fire/crime alarm systems, various safety devices, etc.), and whenever long life expectancy is required even in general purpose electronic equipment or apparatus, please contact your nearest Sanken sales representative to discuss, prior to the use of the products herein.

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- When using the products specified herein by either (i) combining other products or materials therewith or (ii) physically, chemically or otherwise processing or treating the products, please duly consider all possible risks that may result from all such uses in advance and proceed therewith at your own responsibility.
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